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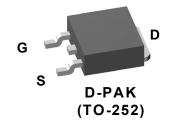
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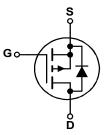
Please note: As part of the Fairchild Semiconductor integration, some of the Fairchild orderable part numbers will need to change in order to meet ON Semiconductor's system requirements. Since the ON Semiconductor product management systems do not have the ability to manage part nomenclature that utilizes an underscore (_), the underscore (_) in the Fairchild part numbers will be changed to a dash (-). This document may contain device numbers with an underscore (_). Please check the ON Semiconductor website to verify the updated device numbers. The most current and up-to-date ordering information can be found at www.onsemi.com. Please email any questions regarding the system integration to Fairchild_questions@onsemi.com.

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FAIRCHILD FDD4243 40V P-Channel PowerTrench ⁰ -40V, -14A, 44mΩ	® MOSFET
Features	General Description
■ Max $r_{DS(on)}$ = 44m Ω at V_{GS} = -10V, I_D = -6.7A ■ Max $r_{DS(on)}$ = 64m Ω at V_{GS} = -4.5V, I_D = -5.5A ■ High performance trench technology for extremely low $r_{DS(on)}$	This P-Channel MOSFET has been produced using Fairchild Semiconductor's proprietary PowerTrench [®] technology to deliver low r _{DS(on)} and optimized Bvdss capability to offer superior performance benefit in the applications.
RoHS Compliant	Application Inverter

Power Supplies





MOSFET Maximum Ratings T_C = 25°C unless otherwise noted

Symbol	Parameter			Ratings	Units	
V _{DS}	Drain to Source Voltage			-40	V	
V _{GS}	Gate to Source Voltage			±20	V	
	Drain Current -Continuous (Package limited)	T _C = 25°C		-14		
,	-Continuous (Silicon limited)	T _C = 25°C	(Note 1)	-24	•	
D	-Continuous	T _A = 25°C	(Note 1a)	-6.7	Α	
	-Pulsed			-60		
E _{AS}	Single Pulse Avalanche Energy		(Note 3)	84	mJ	
D	Power Dissipation	T _C = 25°C		42	W	
P _D	Power Dissipation		(Note 1a)	3		
T _J , T _{STG}	Operating and Storage Junction Temperature Rang	je		-55 to +150	°C	

Thermal Characteristics

$R_{\theta JC}$	Thermal Resistance, Junction to Case	3.0	°C/W
$R_{ ext{ heta}JA}$	Thermal Resistance, Junction to Ambient (Note 1	a) 40	C/VV

Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FDD4243	FDD4243	D-PAK(TO-252)	13"	16mm	2500 units

FDD4243 40V
P-Channel
PowerTrench [®]
MOSFET

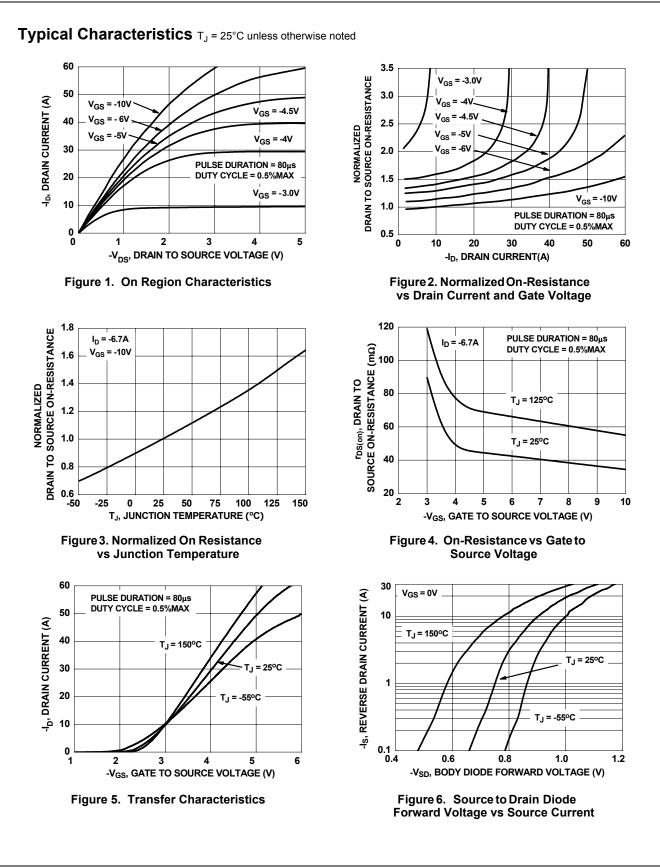
Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Off Chara	acteristics					
BV _{DSS}	Drain to Source Breakdown Voltage	I_{D} = -250 μ A, V _{GS} = 0V	-40			V
ΔBV _{DSS} ΔT _J	Breakdown Voltage Temperature Coefficient	$I_D = -250 \mu A$, referenced to $25^{\circ}C$		-32		mV/°C
DSS	Zero Gate Voltage Drain Current	$V_{DS} = -32V,$ $V_{GS} = 0V$ $T_{J} = 125^{\circ}C$			-1 -100	μA
GSS	Gate to Source Leakage Current	$V_{GS} = \pm 20V, V_{DS} = 0V$			±100	nA
	acteristics				1	1
V _{GS(th)}	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}, I_{D} = -250 \mu A$	-1.4	-1.6	-3.0	V
$\frac{\Delta V_{GS(th)}}{\Delta T_{.l}}$	Gate to Source Threshold Voltage Temperature Coefficient	$I_D = -250\mu$ A, referenced to 25°C		4.7		mV/°C
0	Drain to Source On Resistance	V _{GS} = -10V, I _D = -6.7A		36	44	
DS(on)		V _{GS} = -4.5V, I _D = -5.5A		48	64	mΩ
20(01)		V _{GS} = -10V, I _D = -6.7A, T _J = 125°C		53	69	
9 _{FS}	Forward Transconductance	$V_{DS} = -5V, I_{D} = -6.7A$		16		S
913		$v_{\rm DS} = -3v, \ {\rm ID} = -0.7{\rm A}$		10		5
Dynamic	Characteristics Input Capacitance			1165	1550	pF
Dynamic C _{iss} C _{oss}	Characteristics Input Capacitance Output Capacitance	V _{DS} = -30V, V _D = -0.7A			1550 220	
Dynamic C _{iss} C _{oss} C _{rss}	Characteristics	– V _{DS} = -20V, V _{GS} = 0V, f = 1MHz		1165 165 90		pF
Dynamic C _{iss} C _{oss} C _{rss}	Characteristics Input Capacitance Output Capacitance			1165 165	220	pF pF
Dynamic C _{iss} C _{oss} C _{rss}	Characteristics Input Capacitance Output Capacitance Reverse Transfer Capacitance	– V _{DS} = -20V, V _{GS} = 0V, f = 1MHz		1165 165 90	220	pF pF pF
Dynamic C _{iss} C _{oss} C _{rss} R _g Switching	Characteristics Input Capacitance Output Capacitance Reverse Transfer Capacitance Gate Resistance	V _{DS} = -20V, V _{GS} = 0V, f = 1MHz f = 1MHz		1165 165 90	220	pF pF pF
Dynamic C _{iss} C _{oss} C _{rss} Rg Switching	Characteristics Input Capacitance Output Capacitance Reverse Transfer Capacitance Gate Resistance g Characteristics	$V_{DS} = -20V, V_{GS} = 0V,$ f = 1MHz f = 1MHz $V_{DD} = -20V, I_D = -6.7A$		1165 165 90 4	220 135	pF pF pF Ω
Dynamic C _{iss} C _{oss} C _{rss} R _g Switching	Characteristics Input Capacitance Output Capacitance Reverse Transfer Capacitance Gate Resistance g Characteristics Turn-On Delay Time	V _{DS} = -20V, V _{GS} = 0V, f = 1MHz f = 1MHz		1165 165 90 4 6	220 135 12	pF pF pF Ω ns
Dynamic Ciss Coss Crss Rg Switching d(on) r d(off)	Characteristics Input Capacitance Output Capacitance Reverse Transfer Capacitance Gate Resistance g Characteristics Turn-On Delay Time Rise Time	$V_{DS} = -20V, V_{GS} = 0V,$ f = 1MHz f = 1MHz $V_{DD} = -20V, I_D = -6.7A$		1165 165 90 4 6 15	220 135 12 26	pF pF pF Ω ns
Dynamic Ciss Coss Crss Rg Switching d(on) fr d(off) fr	Characteristics Input Capacitance Output Capacitance Reverse Transfer Capacitance Gate Resistance g Characteristics Turn-On Delay Time Rise Time Turn-Off Delay Time	$V_{DS} = -20V, V_{GS} = 0V,$ f = 1MHz f = 1MHz $V_{DD} = -20V, I_{D} = -6.7A$ $V_{GS} = -10V, R_{GEN} = 6\Omega$		1165 165 90 4 6 15 22	220 135 12 26 35	pF pF Ω ns ns
Dynamic C _{iss} C _{oss} C _{rss} Rg Switching d(on) f d(off) f Q _{g(TOT)}	Characteristics Input Capacitance Output Capacitance Reverse Transfer Capacitance Gate Resistance g Characteristics Turn-On Delay Time Rise Time Turn-Off Delay Time Fall Time	$V_{DS} = -20V, V_{GS} = 0V,$ f = 1MHz f = 1MHz $V_{DD} = -20V, I_D = -6.7A$		1165 165 90 4 6 15 22 7	220 135 12 26 35 14	pF pF Ω ns ns ns ns
Dynamic Ciss Coss Crss Rg Switching Ed(on) Er Ed(off) Ef Qg(TOT) Qgs	Characteristics Input Capacitance Output Capacitance Reverse Transfer Capacitance Gate Resistance g Characteristics Turn-On Delay Time Rise Time Turn-Off Delay Time Fall Time Total Gate Charge at 10V	$V_{DS} = -20V, V_{GS} = 0V,$ f = 1MHz f = 1MHz $V_{DD} = -20V, I_D = -6.7A$ $V_{GS} = -10V, R_{GEN} = 6\Omega$ $V_{DD} = -20V, I_D = -6.7A$		1165 165 90 4 6 15 22 7 21	220 135 12 26 35 14	pF pF Ω ns ns ns ns nc
Dynamic C _{iss} C _{oss} C _{rss} R _g Switching td(on) tr td(off) tf Q _{g(TOT)} Q _{gs} Q _{gd}	Characteristics Input Capacitance Output Capacitance Reverse Transfer Capacitance Gate Resistance g Characteristics Turn-On Delay Time Rise Time Turn-Off Delay Time Fall Time Total Gate Charge at 10V Gate to Source Gate Charge	$V_{DS} = -20V, V_{GS} = 0V,$ f = 1MHz f = 1MHz $V_{DD} = -20V, I_D = -6.7A$ $V_{GS} = -10V, R_{GEN} = 6\Omega$ $V_{DD} = -20V, I_D = -6.7A$		1165 165 90 4 6 15 22 7 21 3.4	220 135 12 26 35 14	pF pF pF Ω ns ns ns ns ns nc
Dynamic G_{iss} C_{oss} C_{rss} R_g Switching $t_{d(on)}$ t_r $t_{d(off)}$ t_f $Q_{g(TOT)}$ Q_{gg} Q_{gd} Drain-Sol	Characteristics Input Capacitance Output Capacitance Reverse Transfer Capacitance Gate Resistance g Characteristics Turn-On Delay Time Rise Time Turn-Off Delay Time Fall Time Total Gate Charge at 10V Gate to Drain "Miller" Charge	$V_{DS} = -20V, V_{GS} = 0V,$ f = 1MHz f = 1MHz $V_{DD} = -20V, I_D = -6.7A$ $V_{GS} = -10V, R_{GEN} = 6\Omega$ $V_{DD} = -20V, I_D = -6.7A$		1165 165 90 4 6 15 22 7 21 3.4	220 135 12 26 35 14	pF pF pF Ω ns ns ns ns ns nc
Dynamic C _{iss} C _{oss} C _{rss} R _g Switching t _d (on) t _r t _d (off) t _f Q _{g(TOT)} Q _{gs} Q _{gd}	Characteristics Input Capacitance Output Capacitance Reverse Transfer Capacitance Gate Resistance GCharacteristics Turn-On Delay Time Rise Time Turn-Off Delay Time Fall Time Total Gate Charge at 10V Gate to Source Gate Charge Gate to Drain "Miller" Charge Urce Diode Characteristics	$V_{DS} = -20V, V_{GS} = 0V,$ f = 1MHz f = 1MHz $V_{DD} = -20V, I_D = -6.7A$ $V_{GS} = -10V, R_{GEN} = 6\Omega$ $V_{DD} = -20V, I_D = -6.7A$ $V_{GS} = -10V$		1165 165 90 4 6 15 22 7 21 3.4 4	220 135 12 26 35 14 29	pF pF pF ns ns ns ns ns nc nC

Notes:
 1: R_{0JA} is sum of junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins. R_{0JC} is guaranteed by design while R_{0JC} is determined by the user's board design.

a. 40°C/W when mounted on a 1 in $^2\,\text{pad}$ of 2 oz copper

b. 96°C/W when mounted on $% \mathcal{A}^{(0)}$ a minimum pad.

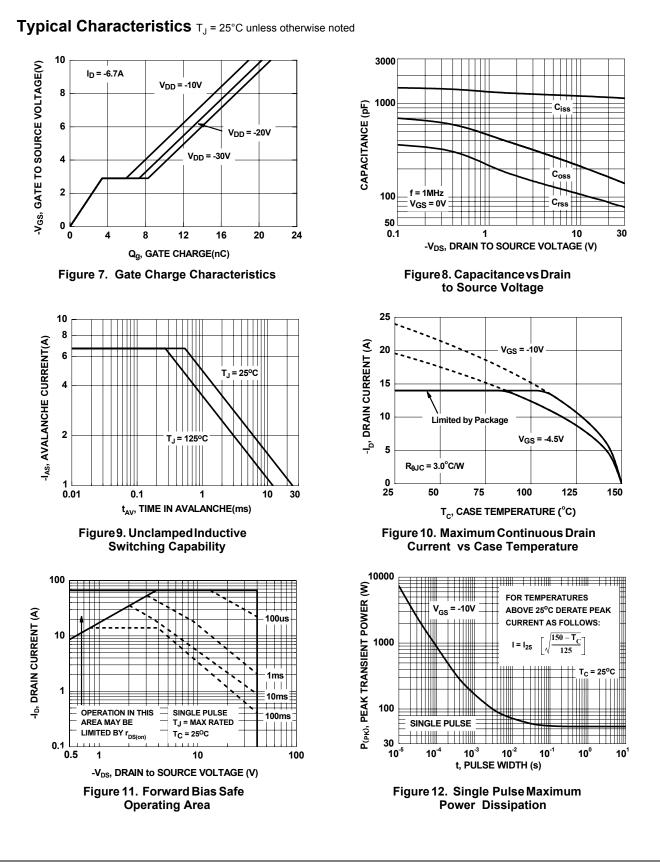
 $2: \mbox{ Pulse Test: Pulse Width < } 300 \mbox{ } \mbox{$



FDD4243 Rev. 1.3

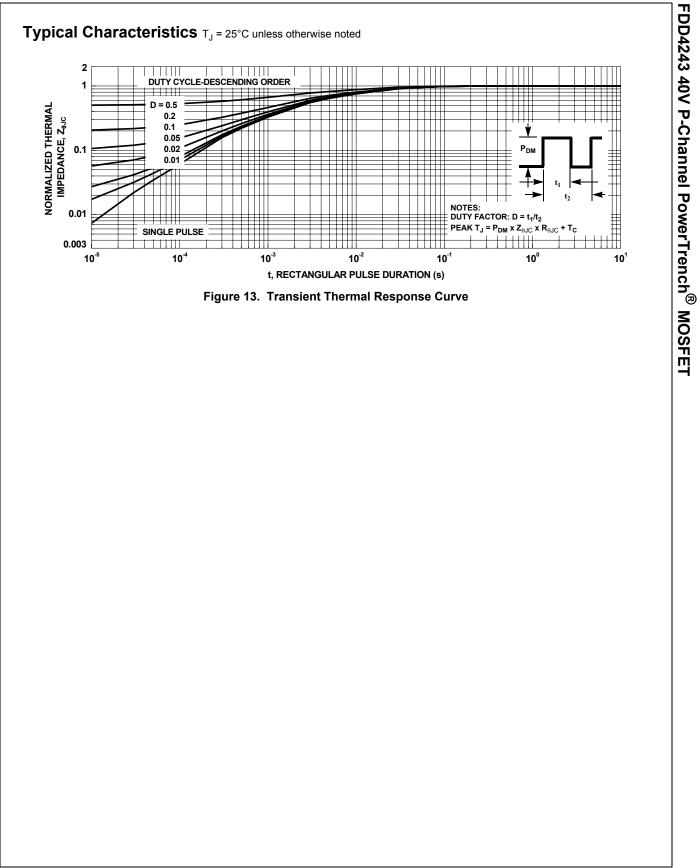
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FDD4243 40V P-Channel PowerTrench[®] MOSFET



FDD4243 Rev. 1.3



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